

Status:	CLOSED	Start date:	2022-09-05
Priority:	High	Due date:	
Assignee:	SZ HW Test-曾小文	% Done:	0%
Category:	EE	Estimated time:	0.00 hour
Target version:			
Need_Info:	--	Found Version:	2022.08.25
Resolution:	--	Degrated:	--
Severity:	Major	Verified Version:	
Reproducibility:	Every time	Fixed Version:	
Test Type:	Release Test	Root cause:	
Description			
RE01 电场辐射发射（ALSE）：0.1MHz-1GHz 辐射Fail			

History

- #1 - 2022-09-05 14:12 - 项目二组_SD3 曾小文
- Priority changed from Normal to High
- Severity changed from Normal to Major
- #2 - 2022-09-14 11:33 - CD TPM-申艳艳
- Category set to EE
- #3 - 2022-09-14 13:48 - SZ HW Test-曾小文
- Assignee set to SZ-硬件二组_SD3 王苗
- #4 - 2022-11-01 14:34 - SZ-硬件二组_SD3 王苗
- Status changed from New to ASSIGNED
- Assignee changed from SZ-硬件二组_SD3 王苗 to SZ HW Test-曾小文
- EVT2的机器RE实验Fail项目，整改屏幕后在SGS福永实验室复测PASS.
- #5 - 2022-11-02 13:29 - SZ HW Test-曾小文
- Status changed from ASSIGNED to RESOLVED
- #6 - 2022-11-02 13:29 - SZ HW Test-曾小文
- Status changed from RESOLVED to VERIFIED
- #7 - 2022-11-02 13:29 - SZ HW Test-曾小文
- Status changed from VERIFIED to CLOSED